#### **Features**

- Low Forward Voltage ( $V_{\text{F}}$ ) Drop with Positive Temperature Coefficient
- Zero Reverse Recovery Current / Forward Recovery Voltage
- Temperature-Independent Switching Behavior

#### **Applications**

- **Battery Chargers**
- Solar & Renewable Energy Power Conversion
- **Industrial Power Supplies**
- Boost Diodes in PFC & DC-DC











**Maximum Ratings**(T = 25°C unless otherwise specified)

Parameter	Symbol	Value	Unit	Test Conditions	Note	
Repetitive Peak Reverse Voltage	V <sub>RRM</sub>	1200	V			
DC Blocking Voltage	V <sub>DC</sub>	1200	V			
Continuous Forward Current	I <sub>F</sub>	94	A	T <sub>J</sub> = 25 °C	Fig. 3	
		45		T <sub>J</sub> = 135 °C		
		30		T <sub>J</sub> = 155 °C		
Repetitive Peak Forward	I <sub>FRM</sub>	121		T <sub>c</sub> = 25 °C, t <sub>p</sub> =10 ms, Half Sine Pulse		
Surge Current		68		T <sub>c</sub> =110 °C, t <sub>p</sub> =10 ms, Half Sine Pulse		
Non-Repetitive Forward	I <sub>FSM</sub>	233		T <sub>c</sub> =25 °C, t <sub>p</sub> =10 ms, Half Sine Pulse		
Surge Current		209		T <sub>c</sub> =110 °C, t <sub>p</sub> =10 ms, Half Sine Pulse		
Power Dissipation	P <sub>tot</sub>	441	W	T <sub>c</sub> = 25 °C	Fig. 4	
		191		T <sub>c</sub> = 110 °C		
i²t Value	∫ i²t	271	A <sup>2</sup> s	$T_c = 25  ^{\circ}\text{C},  t_p = 10  \text{ms}$		
		218		$T_c = 110  ^{\circ}\text{C},  t_p = 10  \text{ms}$		

# Silicon Carbide Schottky Diode

#### **Electrical Characteristics**

Parameter	Symbol	Тур.	Max.	Units	Test Conditions	Note	
[	\ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \	1.5	1.8	V	I <sub>F</sub> = 30 A, T <sub>J</sub> = 25 °C	Fig. 1	
Forward Voltage	V <sub>F</sub>	2.2	3		I <sub>F</sub> = 30 A, T <sub>J</sub> = 175 °C		
Reverse Current		40	250		V <sub>R</sub> = 1200 V, T <sub>J</sub> = 25 °C	Fig. 2	
	I <sub>R</sub>	70	450	μΑ	V <sub>R</sub> = 1200 V, T <sub>J</sub> = 175 °C		
Total Capacitive Charge	$Q_c$	152		nC	V <sub>R</sub> = 800 V, T <sub>J</sub> = 25 °C	Fig. 5	
		2,177			$V_R = 0 \text{ V}, T_J = 25 \text{ °C}, f = 1 \text{ MHz}$		
Total Capacitance	С	136		pF	$V_R = 400 \text{ V}, T_J = 25 \text{ °C}, f = 1 \text{ MHz}$	Fig. 6	
		100			V <sub>R</sub> = 800 V, T <sub>J</sub> = 25 °C, f = 1 MHz		
Capacitance Stored Energy	E <sub>c</sub>	44		μJ	V <sub>R</sub> = 800 V	Fig. 7	

Note

SiC Schottky Diodes are majority carrier devices, so there is no reverse recovery charge.

### **Thermal & Mechanical Characteristics**

Parameter	Symbol	Value	Units	Note
Thermal Resistance, Junction to Case (Typ.)	R <sub>e, JC</sub>	0.34	°C / W	
Operating Junction & Storage Temperature	$T_{J}$ , $T_{stg}$	-55 to +175	00	Fig. 8
Maximum Processing Temperature	T <sub>PROC</sub>	325	C	10 min. Maximum

#### **Electrostatic Discharge (ESD) Classifications**

Parameter	Symbol	Value	
Human Body Model	НВМ	Class 3B (≥ 8000 V)	
Charge Device Model	CDM	Class C3 (≥ 1000 V)	

### **Typical Performance**

**Figure 1. Forward Characteristics** 

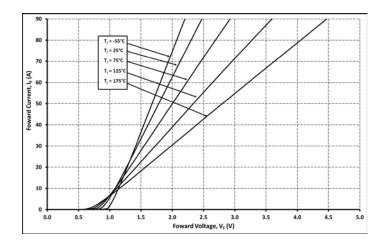


Figure 2. Reverse Characteristics

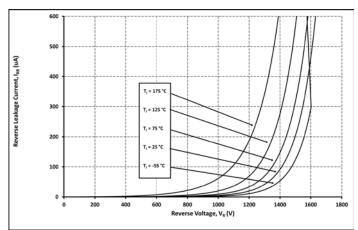


Figure 3. Current Derating

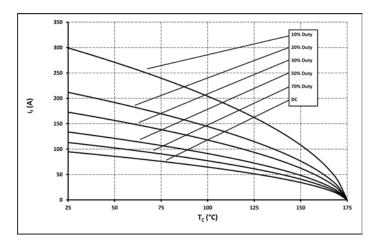


Figure 4. Power Derating

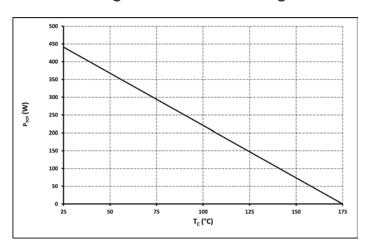


Figure 5. Total Capacitance Charge vs. Reverse Voltage

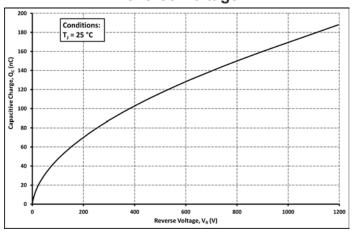
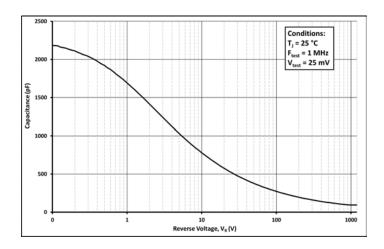


Figure 6. Capacitance vs. Reverse Voltage



### **Typical Performance**

Figure 7. Capacitance Stored Energy

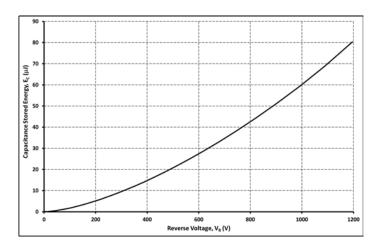
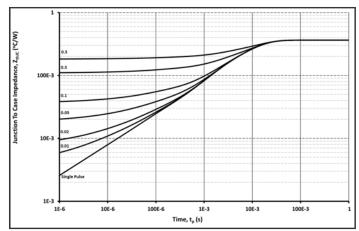
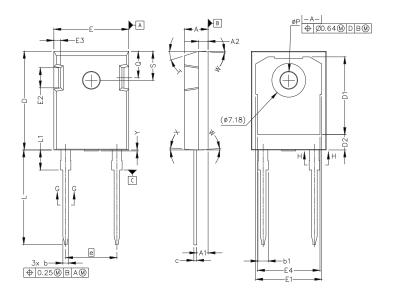


Figure 8. Transient Thermal Impedance



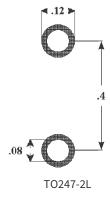
### **Package Dimensions**

Package: TO247-2L All dimensions in mm.



CVAL	MILLIM	ETERS	INCHES		
SYM	MIN	MAX	MIN	MAX	
Α	4.83	5.21	.190	.205	
A1	2.29	2.54	.090	.100	
A2	1.91	2.16	.075	.085	
b'	1.07	1.28	.042	.050	
b	1.07	1.33	.042	.052	
b1	1.91	2.41	.075	.095	
b2	1.91	2.16	.075	.085	
c'	0.55	0.65	.022	.026	
С	0.55	0.68	.022	.027	
D	20.80	21.10	.819	.831	
D1	16.25	17.35	.640	.683	
D2	2.86	3.16	.112	.124	
E	15.75	16.13	.620	.635	
E1	13.10	14.15	.516	.557	
E2	3.68	5.10	.145	.201	
E3	1.00	1.90	.039	.075	
E4	12.38	13.43	.487	.529	
е	10.88 B		.428	BSC	
L	19.81	20.32	.780	.800	
L1	4.10	4.40	.161	.173	
φP	3.51	3.65	.138	.144	
Q	5.49	6.00	.216	.236	
S	6.04	6.30	.238	.248	
T		17.5° F			
W		3.5° R			
X	4° REF.				
Υ	0	0.50	0	0.020	

## **Recommended Solder Pad Layout**



all units are in inches

#### **Attention**

- Any and all HUA XUAN YANG ELECTRONICS products described or contained herein do not have specifications that can handle applications that require extremely high levels of reliability, such as life-support systems, aircraft's control systems, or other applications whose failure can be reasonably expected to result in serious physical and/or material damage. Consult with your HUA XUAN YANG ELECTRONICS representative nearest you before using any HUA XUAN YANG ELECTRONICS products described or contained herein in such applications.
- HUA XUAN YANG ELECTRONICS assumes no responsibility for equipment failures that result from using products at values that exceed, even momentarily, rated values (such as maximum ratings, operating condition ranges, or other parameters) listed in products specifications of any and all HUA XUAN YANG ELECTRONICS products described or contained herein.
- Specifications of any and all HUA XUAN YANG ELECTRONICS products described or contained herein stipulate the performance, characteristics, and functions of the described products in the independent state, and are not guarantees of the performance, characteristics, and functions of the described products as mounted in the customer's products or equipment. To verify symptoms and states that cannot be evaluated in an independent device, the customer should always evaluate and test devices mounted in the customer's products or equipment.
- HUA XUAN YANG ELECTRONICS CO.,LTD. strives to supply high-quality high-reliability products. However, any and all semiconductor products fail with some probability. It is possible that these probabilistic failures could give rise to accidents or events that could endanger human lives, that could give rise to smoke or fire, or that could cause damage to other property. When designing equipment, adopt safety measures so that these kinds of accidents or events cannot occur. Such measures include but are not limited to protective circuits and error prevention circuits for safe design, redundant design, and structural design.
- In the event that any or all HUA XUAN YANG ELECTRONICS products(including technical data, services) described or contained herein are controlled under any of applicable local export control laws and regulations, such products must not be exported without obtaining the export license from the authorities concerned in accordance with the above law.
- No part of this publication may be reproduced or transmitted in any form or by any means, electronic or mechanical, including photocopying and recording, or any information storage or retrieval system, or otherwise, without the prior written permission of HUA XUAN YANG ELECTRONICS CO.,LTD.
- Information (including circuit diagrams and circuit parameters) herein is for example only; it is not guaranteed for volume production. HUA XUAN YANG ELECTRONICS believes information herein is accurate and reliable, but no guarantees are made or implied regarding its use or any infringements of intellectual property rights or other rights of third parties.
- Any and all information described or contained herein are subject to change without notice due to product/technology improvement, etc.

  When designing equipment, refer to the "Delivery Specification" for the HUA XUAN YANG ELECTRONICS product that you intend to use.